

# VSXX065R18ANA

**Datasheet** 





### 180m $\Omega$ , 650V, N-Channel Power MOSFET

### VSXX065R18ANA

## **General Description**

V <sub>(BR)DSS</sub>	R <sub>DS(ON)_max</sub>	$I_D$
650V	180mΩ@ 10V	21.2A

## **Symbol**

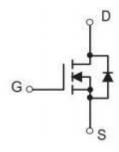


Figure 1 Symbol of VSXX065R18ANA

#### **Features**

- Ultra Low Gate Charge
- Ultra Low R<sub>DS(ON)</sub>
- Fast switching capability
- Robust design with better EAS performance
- EMI Improved

## **Application**

- UPS, Inverter, etc
- Solar
- TV Power
- High Power AC/DC Power Supply

## Package Type



Figure 2 Package Type of VSXX065R18ANA

## **Ordering Information**

Product Name	Package
VSTD065R18AND	TO-220F
VSTA065R18AND	TO-220C
VSTN065R18AND	TO-262
VSTF065R18AND	TO-247



### 180m $\Omega$ , 650V, N-Channel Power MOSFET

#### VSXX065R18ANA

### Absolute Maximum Ratings<sup>Note1</sup>

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V <sub>DSS</sub>	650	V
Gate-Source Voltage	V <sub>GSS</sub>	±30	V
Continuous Drain Current T <sub>C</sub> = 25 °C	т	21.2	
Continuous Drain Current T <sub>C</sub> = 100 °C	$I_{D}$	9.5	
Pulsed Drain Current Note2	Ірм	64	A
Continuous diode forward current	Is	21.2	
Diode pulsed current	Is.pulse	64	
Single Pulsed Avalanche Energy <sup>Note3</sup>	Eas	505	T
Avalanche Energy, RepetitiveNote2	Ear	0.7	mJ
Avalanche Current, RepetitiveNote2	Iar	3.6	A
MOSFET dv/dt Ruggedness, V <sub>DS</sub> <=480V	dv/dt	50	V/ns
Reverse Diode dv/dt, V <sub>DS</sub> <=480V, I <sub>SD</sub> <=I <sub>D</sub>	dv/dt	15	V/ns
Junction Temperature	$T_J$	150	
Storage Temperature	Tstg	-55 to 150	°C
Lead Temperature (Soldering, 10 sec)	TLEAD	260	

#### Note:

- 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.
- 2. Repetitive Rating: Pulse width limited by maximum junction temperature
- 3.  $I_{AS}$ = 3.6A,  $V_{DD}$ = 60V,  $R_G$ = 25 $\Omega$ , Starting  $T_J$ = 25 $^{\circ}$ C





### VSXX065R18ANA

### **Electrical Characteristics** (T<sub>J</sub>= 25 °C, unless otherwise specified)

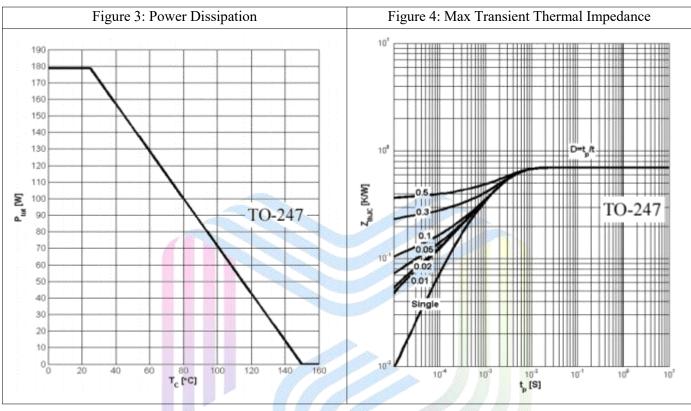
Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
Statistic Characteristics						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> = 250uA	650			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 650V, V_{GS} = 0V$			1	uA
Gate-Body Leakage Current	-	$V_{GS} = 30V, V_{DS} = 0V$			0.1	
Gate-Body Leakage Current	Igss	$V_{GS} = -30V, V_{DS} = 0V$			- 1.0	uA
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA	2.4	3.4	4.4	V
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	$V_{GS}=10V, I_{D}=10A$		160	180	mΩ
Gate Resistance	Rg	f=1MHz, Open drain		1.7		Ω
Dynamic Characteristics						
Input Capacitance	Ciss	V <sub>DS</sub> =50V		1630		pF
Output Capacitance	Coss	V <sub>GS</sub> =0V		110		pF
Reverse Transfer Capacitance	Crss	f=1MHz		22		pF
Effective output capacitance, energy				71		
related <sup>NOTE4</sup>	C <sub>O(er)</sub>	V <sub>GS</sub> =0V		/1		пF
Effective output capacitance, time		V <sub>DS</sub> =0480V		301		шг
related <sup>NOTE5</sup>	C <sub>O(tr)</sub>			301		
Total Gate Charge	Qg	V <sub>DS</sub> =480V		10.6		
Gate-Source Charge	$Q_{gs}$	$V_{DS}=480V$ $V_{GS}=0$ to $10V$	AV A	12.2		nC
Gate-Drain Charge	Qgd	$I_{D}$ = 10A		38		
Gate Plateau Voltage	V <sub>plateau</sub>	ID- 10A		5.5		V
<b>Switching Parameters</b>	11					
Turn-on Delay Time	td(on)	$V_{DS} = 400V$		11		
Turn-on Rise Time	$t_{\rm r}$	$V_{GS}=10V$		10		***
Turn-offDelay Time	$t_{d(off)}$	$I_D=10A$		76		ns
Turn-offFall Time	$t_{ m f}$	$R_G=3.4\Omega$		8		
Diode Characteristics				$\setminus$ /		
Diode Forward Voltage	V <sub>SD</sub>	$V_{GS}=0V$ , $I_{S}=10A$		0.83	1.1	V
Reverse Recovery Time	t <sub>rr</sub>	$I_S=10A$	- 6	330	<b>5</b> 8	ns
Reverse Recovery Charge	Qrr	$V_R=400V$		4.5		пC
Peak Reverse Recovery Current	I <sub>rrm</sub>	di/dt=100A/us		27		A

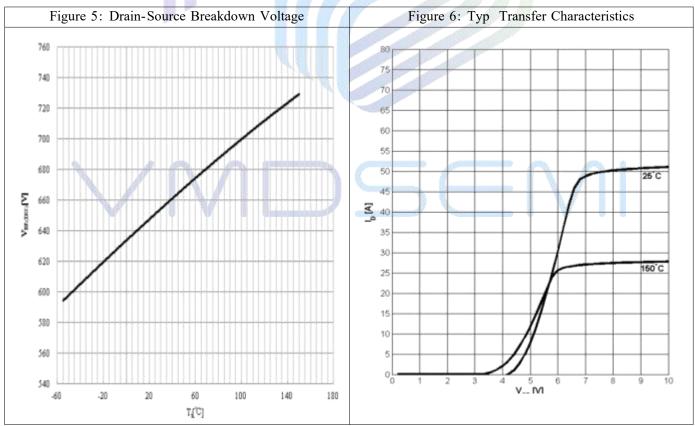
#### Note:

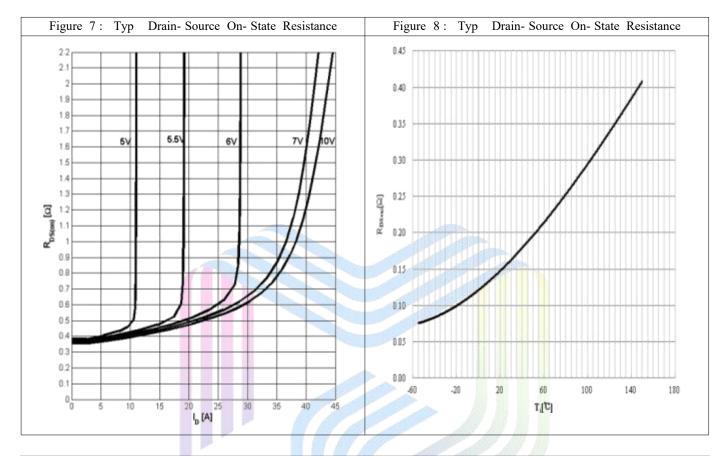
- 4.  $C_{O(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{OSS}$  while  $V_{DS}$  is rising from 0 to 480V
- 5.  $C_{O\,(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{OSS}$  while  $V_{DS}$  is rising from 0 to 480 V

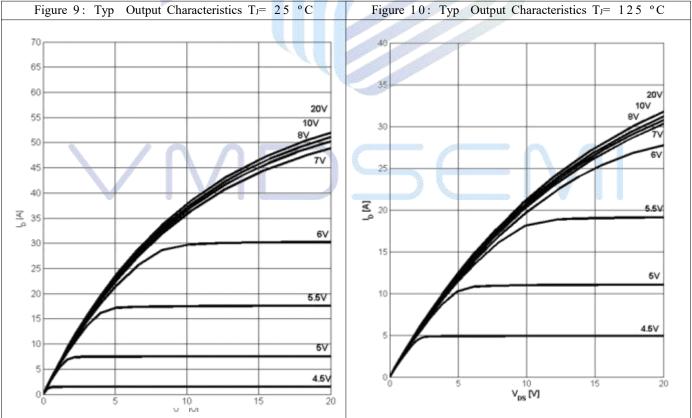


## **Typical Performance Characteristics**



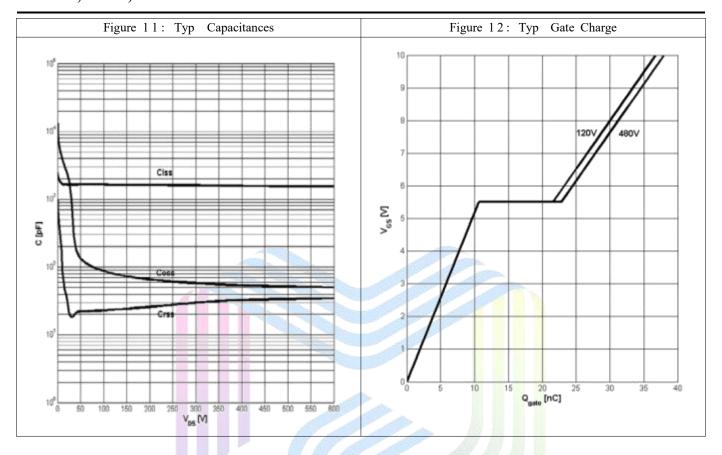


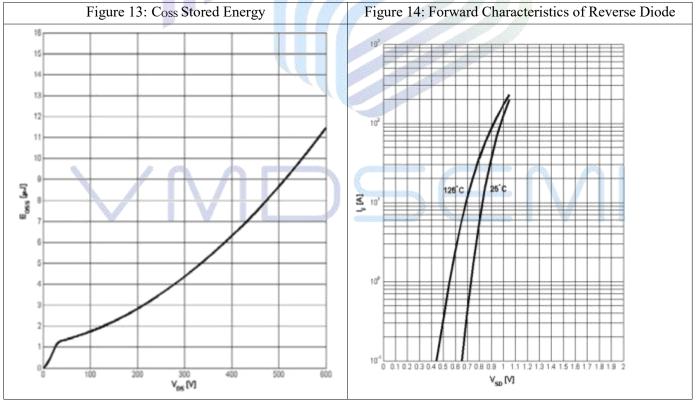






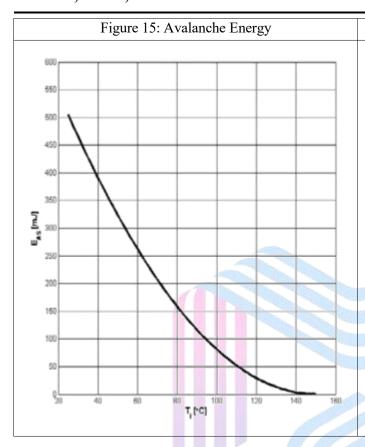
### VSXX065R18ANA

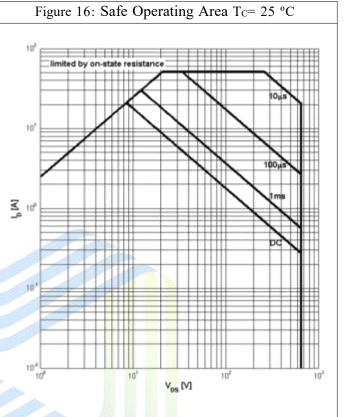


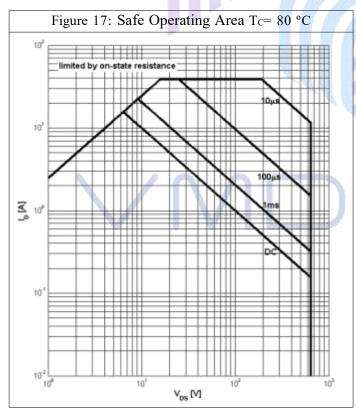




### VSXX065R18ANA





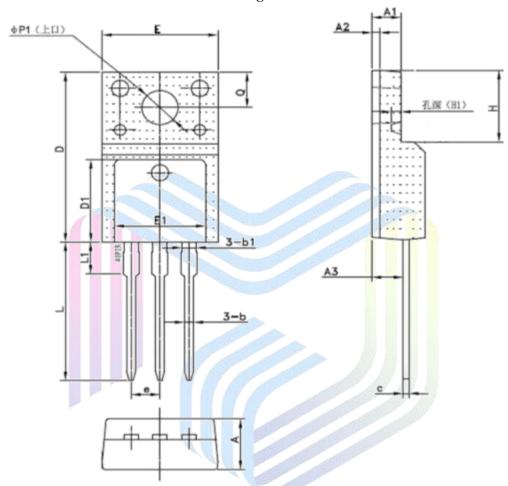


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## **Mechanical Dimensions:**

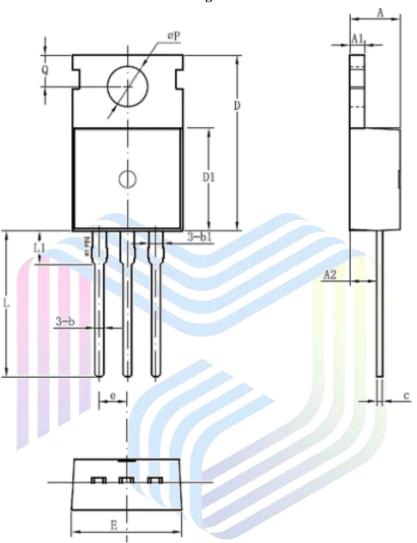
**TO-220F Package Information** 



		Dimensions(mm)		
Symbol	MI-		••	
	Min.	Тур.	Max.	
A	4.30	4.70	4.90	
A1	2.34	2.54	2.90	
A2	-	0.70	_ : \ /	
A3	2.56	2.76	2.96	
b	0.55		0.95	
b1	-	1.28		
С	0.42	0.50	0.70	
D	14.70	-	16.07	
D1	-	7.70	-	
E	9.96	10.16	10.36	
E1	-	8.00		
е		2.54(BSC)		
Н	-	6.70		
(H1)	-	(0.81)	-	
L	12.48	12.98	13.50	
L1	-	2.93	-	
ФР1	-	3.18	-	
Q	2.90	3.30	3.50	



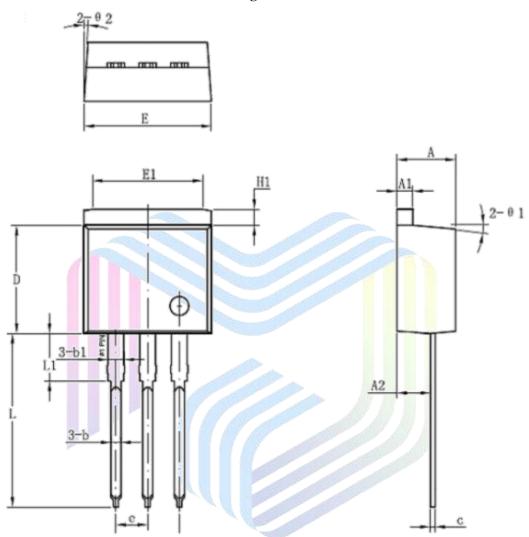
#### **TO-220C Package Information**



Symbol	Dimensions(mm)			
	Min.	Тур.	Max.	
A	4.30	4.50	4.70	
A1	1.20	1.30	1.40	
A2	2.20	2.40	2.60	
b	0.70	0.80	0.95	
b1		1.27	-	
С	0.40	0.50	0.65	
D	15.20	15.70	16.20	
D1	9.00	9.20	9.40	
E	9.70	10.00	10.20	
e	2.54(BSC)			
L	12.60	13.08	13.60	
L1	-	3.00	-	
ФР	3.50	3.60	3.80	
Q	2.60	2.80	3.00	



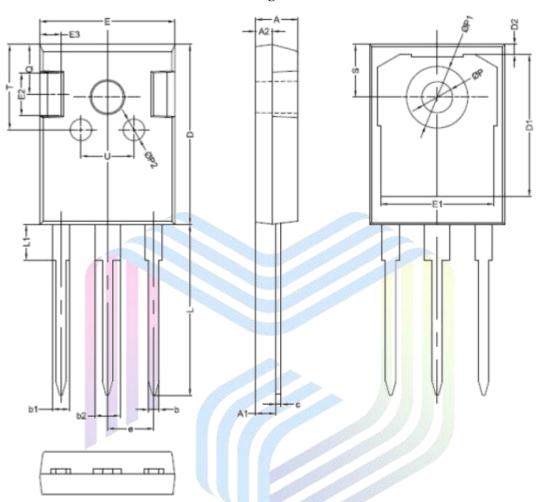
#### **TO-262 Package Information**



Symbol		Dimensions(mm)	
Symbol	Min.	Тур.	Max.
A	4.30	4.65	4.85
A1	1.17	1.27	1.40
A2	2.20	-)	2.89
b	0.70	0.81	0.96
b1	-	1.27	-
С	0.36	0.40	0.61
D	8.55	-	9.4
E	9.80	10.10	10.31
E1	-	8.80	-
e		2.54(BSC)	
H1	1.00	1.25	1.40
L	12.60	-	14.08
L1	-	3.8	-
91		5°	
θ2		4°	



**TO-247 Package Information** 



Symbol	Dimensions(mm)		
Syllibol	Min.	Тур.	Max.
Α	4.80	5.00	5.20
A1	2.21	2.41	2.61
A2	1.90	2.00	2.10
b	1.10	1.20	1.35
b1	-	2.00	-
b2	-	3.00	-
С	0.55	0.60	0.75
D	20.80	21.00	21.20
D1	-	16.55	-
D2	-	1.20	-
E	15.60	15.80	16.00
E1	-	13.30	-

Symbol	Dimensions(mm)		
Symbol	Min.	Тур.	Max.
E2	-	5.00	
E3	-	2.50	-
е		5.44(BSC)	
L	19.42	19.92	20.42
L1	-	4.13	-
Р	3.50	3.60	3.70
P1	-	*	7.40
P2	-	2.50	-
Q	-	5.80	*
S	6.05	6.15	6.25
T	-	10.00	-
U	-	6.20	-

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